

## AO4403

# P-Channel Enhancement Mode Field Effect Transistor

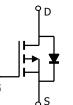
### **General Description**

The AO4403 uses advanced trench technology to provide excellent  $R_{DS(ON)}$ , low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications. The source leads are separated to allow a Kelvin connection to the source, which may be used to bypass the source inductance.

#### Features

$$\begin{split} V_{DS} \left( V \right) &= -30V \\ I_D &= -6.1 \ A \\ R_{DS(ON)} &< 46m\Omega \ (V_{GS} &= -10V) \\ R_{DS(ON)} &< 61m\Omega \ (V_{GS} &= -4.5V) \\ R_{DS(ON)} &< 117m\Omega \ (V_{GS} &= -2.5V) \end{split}$$





Absolute Maximum Ratings T <sub>A</sub> =25°C unless otherwise noted									
Parameter		Maximum	Units						
Drain-Source Voltage		-30	V						
	$V_{GS}$	±12	V						
T <sub>A</sub> =25°C		-6.1							
T <sub>A</sub> =70°C	I <sub>D</sub>	-5.1	А						
Pulsed Drain Current <sup>B</sup>		-60							
T <sub>A</sub> =25°C	P_	3	- w						
T <sub>A</sub> =70°C	'D	2.1							
Junction and Storage Temperature Range		-55 to 150	°C						
	$ \begin{array}{c}                                     $	$\begin{array}{c c} & Symbol \\ \hline P & V_{DS} \\ \hline P & V_{GS} \\ \hline T_A = 25^{\circ}C \\ \hline T_A = 70^{\circ}C \\ \hline P_D \\ \hline T_A = 70^{\circ}C \\ \hline T_A = 70^{\circ}C \\ \hline \end{array}$	$ \begin{array}{c c c c c c c c c c c c c c c c c c c $						

Thermal Characteristics								
Parameter		Symbol	Тур	Мах	Units			
Maximum Junction-to-Ambient <sup>A</sup>	t ≤ 10s	D	31	40	°C/W			
Maximum Junction-to-Ambient <sup>A</sup>	Steady-State	R <sub>0JA</sub>	59	75	°C/W			
Maximum Junction-to-Lead <sup>C</sup>	Steady-State	$R_{ ext{ heta}JL}$	16	24	°C/W			



#### Electrical Characteristics (T<sub>J</sub>=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC	PARAMETERS						
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	I <sub>D</sub> =-250μA, V <sub>GS</sub> =0V		-30			V
I <sub>DSS</sub> Zero Gate Voltage Drain Curre	Zero Gate Voltage Drain Current	V <sub>DS</sub> =-24V, V <sub>GS</sub> =0V				-1	μA
	Zero Gale Vollage Drain Current		TJ=55°C			-5	μΑ
I <sub>GSS</sub>	Gate-Body leakage current	V <sub>DS</sub> =0V, V <sub>GS</sub> =±12V				±100	nA
V <sub>GS(th)</sub>	Gate Threshold Voltage	$V_{DS}=V_{GS}$ $I_{D}=-250\mu A$		-0.7	-1	-1.3	V
I <sub>D(ON)</sub>	On state drain current	$V_{GS}$ =-4.5V, $V_{DS}$ =-5V					Α
R <sub>DS(ON)</sub> Static Drain-Source On-Resistance		V <sub>GS</sub> =-10V, I <sub>D</sub> =-6.1A			38	46	mΩ
	Static Drain Source On Pesistance		TJ=125°C			70	1115.2
	V <sub>GS</sub> =-4.5V, I <sub>D</sub> =-5A			49	61	mΩ	
		V <sub>GS</sub> =-2.5V, I <sub>D</sub> =-1A			76	117	mΩ
<b>g</b> <sub>FS</sub>	Forward Transconductance	V <sub>DS</sub> =-5V, I <sub>D</sub> =-5A		7	11		S
$V_{SD}$	Diode Forward Voltage	I <sub>S</sub> =-1A,V <sub>GS</sub> =0V		-0.75	-1	V	
l <sub>s</sub>	Maximum Body-Diode Continuous Curr	rent			-4.2	Α	
DYNAMI	C PARAMETERS		·				
C <sub>iss</sub>	Input Capacitance	V <sub>GS</sub> =0V, V <sub>DS</sub> =-15V, f=1MHz			940		pF
C <sub>oss</sub>	Output Capacitance				104		pF
C <sub>rss</sub>	Reverse Transfer Capacitance				73		pF
R <sub>g</sub>	Gate resistance	V <sub>GS</sub> =0V, V <sub>DS</sub> =0V, f=1MHz			6		Ω
SWITCH	ING PARAMETERS						
Qg	Total Gate Charge	V <sub>GS</sub> =-4.5V, V <sub>DS</sub> =-15V, I <sub>D</sub> =-5A			9.4		nC
Q <sub>gs</sub>	Gate Source Charge				2		nC
Q <sub>gd</sub>	Gate Drain Charge				3		nC
t <sub>D(on)</sub>	Turn-On DelayTime	V <sub>GS</sub> =-10V, V <sub>DS</sub> =-15V, R <sub>L</sub> =2.4Ω, R <sub>GEN</sub> =6Ω			7.6		ns
t <sub>r</sub>	Turn-On Rise Time				8.6		ns
t <sub>D(off)</sub>	Turn-Off DelayTime				44.7		ns
t <sub>f</sub>	Turn-Off Fall Time				16.5		ns
t <sub>rr</sub>	Body Diode Reverse Recovery Time	$I_F$ =-5A, dI/dt=100A/µs		22.7		ns	
Q <sub>rr</sub>	Body Diode Reverse Recovery Charge	I <sub>F</sub> =-5A, dI/dt=100A/μs		15.9		nC	

A: The value of  $R_{0JA}$  is measured with the device mounted on  $1in^2$  FR-4 board with 2oz. Copper, in a still air environment with  $T_A = 25^{\circ}$ C. The value in any a given application depends on the user's specific board design. The current rating is based on the t≤ 10s thermal resistance rating.

B: Repetitive rating, pulse width limited by junction temperature.

C. The R  $_{\rm 0JA}$  is the sum of the thermal impedence from junction to lead R  $_{\rm 0JL}$  and lead to ambient.

D. The static characteristics in Figures 1 to 6,12,14 are obtained using  $80 \mu s$  pulses, duty cycle 0.5% max.

E. These tests are performed with the device mounted on 1 in<sup>2</sup> FR-4 board with 2oz. Copper, in a still air environment with  $T_A=25^{\circ}C$ . The SOA curve provides a single pulse rating.